

RoHS

COMPLIANT

IRFP9240PBF-VB Datasheet

Power MOSFET

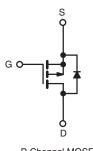
PRODUCT SUMMARY					
V _{DS} (V)	- 100				
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.20			
Q _g (Max.) (nC)	61				
Q _{gs} (nC)	14				
Q _{gd} (nC)	2	9			
Configuration	Single				

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- Isolated Central Mounting Hole
- 175 °C Operating Temperature
- · Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

TO-247AC





P-Channel MOSFET

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V _{DS}	- 100	- V		
Gate-Source Voltage	V _{GS}	± 20			
Continuous Drain Current	V_{GS} at - 10 V $\frac{T_{C} = 25 \text{ °C}}{T_{C} = 100 \text{ °C}}$		- 21		
	V_{GS} at - 10 V $T_C = 100 ^{\circ}C$	I _D	- 15	А	
Pulsed Drain Current ^a		I _{DM}	- 84		
Linear Derating Factor			1.2	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	960	mJ		
Repetitive Avalanche Current ^a		I _{AR}	- 21	A	
Repetitive Avalanche Energy ^a		E _{AR}	18	mJ	
Maximum Power Dissipation	T _C = 25 °C	P _D 180		W	
Peak Diode Recovery dV/dt ^c	•	dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	6-32 or M3 screw		10	lbf ∙ in	
Mounting Torque	0-32 OF IVIS SCIEW		1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = -25$ V, starting $T_J = 25$ °C, L = 3.3 mH, $R_g = 25 \Omega$, $I_{AS} = -21$ A (see fig. 12). c. $I_{SD} \le -21$ A, dl/dt ≤ 200 A/µs, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C. d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

IRFP9240PBF-VB

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THERMAL RESISTANCE RAT	INGS							
PARAMETER	SYMBOL	TYP.	MAX.	MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	40	40 - °C/W				
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-			°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.83	0.83				
SPECIFICATIONS $(T_J = 25 \degree C)$, unless otherw	/ise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-Source Breakdown Voltage	V _{DS}	V_{GS} = 0 V, I _D = - 250 µA		- 100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$v_{GS} = 0 \text{ v}, I_D = -250 \mu\text{A}$ Reference to 25 °C, $I_D = -1 \text{ mA}$		-	- 0.087	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$\begin{tabular}{lllllllllllllllllllllllllllllllllll$		- 2.0	-	- 4.0	V	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA	
Zero Gate Voltage Drain Current	1	$V_{DS} = -100 \text{ V}, V_{GS} = 0 \text{ V}$		-	-	- 100 - 500 μΑ		
	I _{DSS}	V_{DS} = - 80 V, V_{GS} = 0 V, T_J = 150 °C -		-	-		μΑ	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 13 A ^b	-	0.20	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS} = - 50 V, I _D = - 13 A ^b		6.2	-	-	S	

		1					
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = - 25 V, f = 1.0 MHz, see fig. 5		-	1400	-	pF
Output Capacitance	Coss			-	590	-	
Reverse Transfer Capacitance	C _{rss}			-	140	-	
Total Gate Charge	Qg			-	-	61	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$I_D = -19 \text{ A}, V_{DS} = -80 \text{ V},$ see fig. 6 and 13^{b}	-	-	14	nC
Gate-Drain Charge	Q _{gd}			-	-	29	
Turn-On Delay Time	t _{d(on)}	V _{DD} = - 50 V, I _D = - 19 A, R _g = 9.1 Ω, R _D = 2.4 Ω, see fig. 10 ^b		-	16	-	ns
Rise Time	t _r			-	73	-	
Turn-Off Delay Time	t _{d(off)}			-	34	-	
Fall Time	t _f		-		57	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	nH
Internal Source Inductance	L _S			-	13	-	
Drain-Source Body Diode Characteristics	3						
Continuous Source-Drain Diode Current	۱ _S	showing the	MOSFET symbol showing the		-	- 21	А
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	- 84	A
Body Diode Voltage	V _{SD}	T_J = 25 °C, I_S = - 21 A, V_{GS} = 0 V ^b		-	-	- 5.0	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \ ^\circ C$, $I_F = -19 \ A$, $dI/dt = 100 \ A/\mu s^b$		-	130	260	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.35	0.70	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

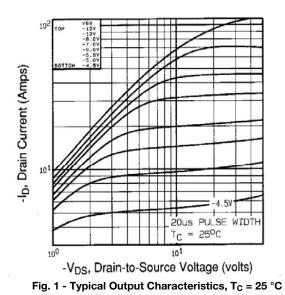
Dynamic

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.







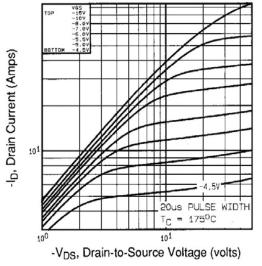


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

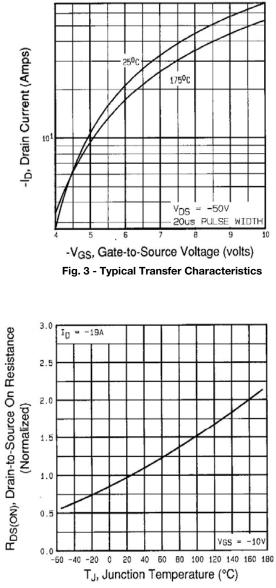


Fig. 4 - Normalized On-Resistance vs. Temperature



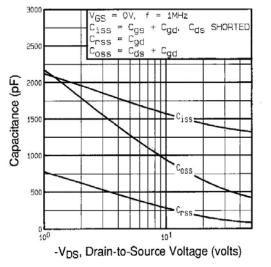
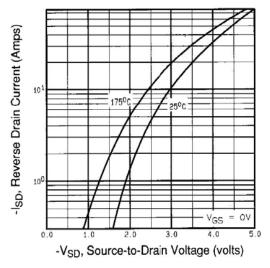
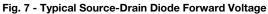


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





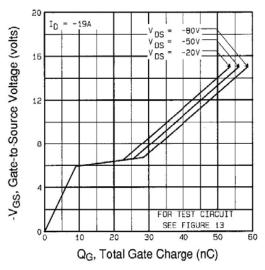


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

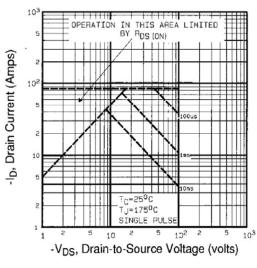


Fig. 8 - Maximum Safe Operating Area



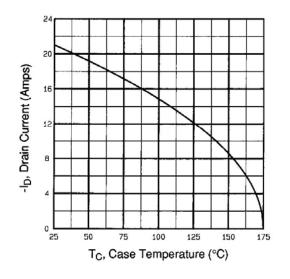


Fig. 9 - Maximum Drain Current vs. Case Temperature

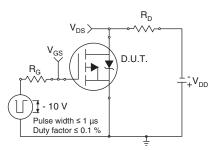


Fig. 10a - Switching Time Test Circuit

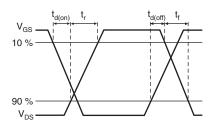


Fig. 10b - Switching Time Waveforms

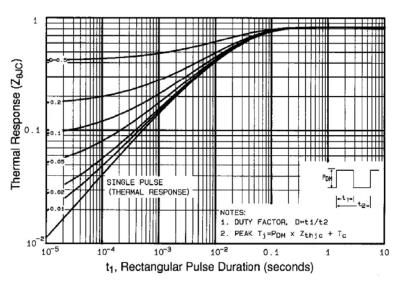


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



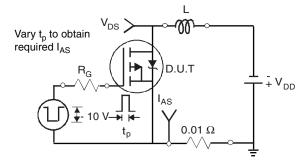


Fig. 12a - Unclamped Inductive Test Circuit

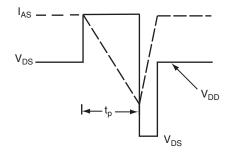


Fig. 12b - Unclamped Inductive Waveforms

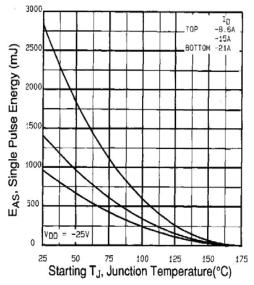


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

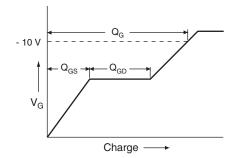


Fig. 13a - Basic Gate Charge Waveform

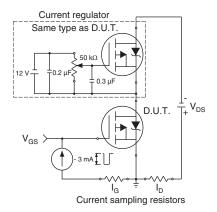
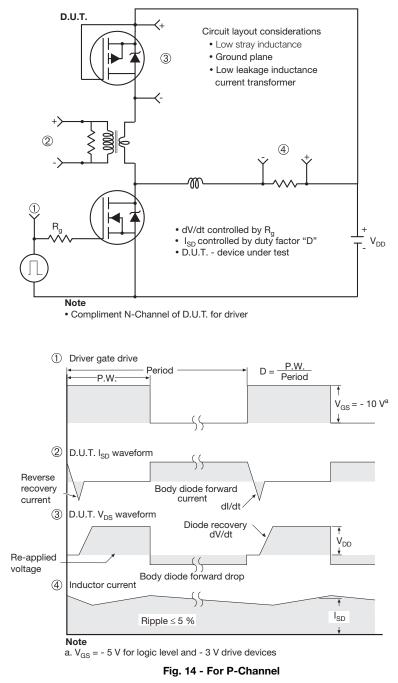


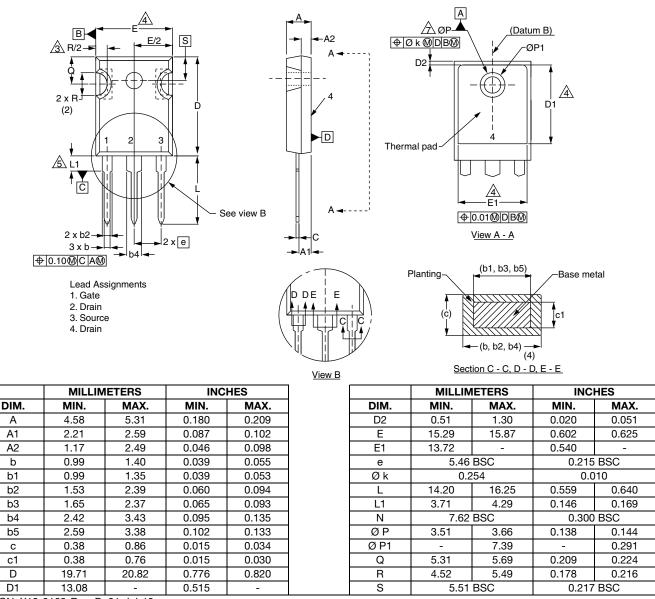
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit







TO-247AC (High Voltage)

ECN: X13-0103-Rev. D, 01-Jul-13

DWG: 5971

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Contour of slot optional.

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.

Thermal pad contour optional with dimensions D1 and E1.
 Lead finish uncontrolled in L1.

6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").

7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.

8. Xian and Mingxin actually photo.



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